

10/549538

PATENT APPLICATION

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IN THE U.S. PATENT AND TRADEMARK OFFICE

September 15, 2005

Applicants : Hitoshi SATO et al  
For : ROTATING MECHANISM OF BIAXIAL HINGE, AND  
PORTABLE TELEPHONE EQUIPPED WITH SAME

PCT International Application No.: PCT/JP2004/015970

PCT International Filing Date: October 21, 2004

U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 4700.P0316US

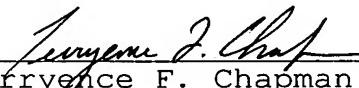
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**INFORMATION DISCLOSURE STATEMENT**

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report or cited in the specification. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,

  
Terryence F. Chapman

TFC/smd

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Encl: Copy of International Search Report  
Form PTO-1449 and one copy of each reference listed  
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336.05/03

INFORMATION DISCLOSURE CITATION		Applicant: Hitoshi SATO et al Ser.No.: Unknown Conf. No.: Unknown Group: Unknown	Filed: Unknown Atty. Docket No.: 4700.P0316US	<b>10/549538</b>
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U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
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	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	JP 2002-155923	5-31-2002	HIGANO et al	Abstract
	AM	JP 2003-120653	04-23-2003	SUDO et al	Abstract
	AN	JP 2003-239943	08-27-2003	HAYASHI	Abstract
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.